

Notice of References Cited		Application/Control No. 10/773,180	Applicant(s)/Patent Under Reexamination LEE ET AL.
		Examiner John D. Lee <i>John D. Lee</i>	Art Unit 2874

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0063944	05-2002	Kim et al.	359/326
*	C	US-6,665,113	12-2003	Aso et al.	359/326
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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